# **ON Semiconductor**

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ON Semiconductor®

# FAN48623 — 2500 mA, Synchronous TinyBoost® Regulator with Bypass Mode

#### **Features**

- Maximum Continuous Load Current: 2500 mA at V<sub>IN</sub> of 2.5 V Boosting V<sub>OUT</sub> to 3.3 V
- Maximum Pulse Load Current of 3.5 A for GSM PAs (1 Slot) and PMIC support simultaneously, V<sub>IN</sub>=3.1 V, V<sub>OUT</sub>=3.4 V
- Up to 97% Efficient
- 4 External Components: 2520 case 0.47 μH Inductor and 0603 Case Size Input and Output Capacitors
- Input Voltage Range: 2.5 V to 5.5 V
- Fixed Output Voltage Options: 3.0 V to 5.0 V
- True Bypass Operation when V<sub>IN</sub> > Target V<sub>OUT</sub>
- Integrated Synchronous Rectifier
- True Load Disconnect
- Forced Bypass Mode
- V<sub>SEL</sub> Control to Optimize Target V<sub>OUT</sub>
- Short-Circuit Protection (SCP)
- Low Operating Quiescent Current
- 16-Bump, 1.81 mm x 1.81 mm, 0.4 mm Pitch, WLCSP

## **Applications**

- Boost for Low Voltage Li-ion Batteries, Brow nout Prevention, System PMIC LDOs Supplies, and 2G/3G/4G RF PA Supplies
- Smart Phones, Tablets, Portable Devices

## **Description**

The FAN48623 allows systems to take advantage of new battery chemistries that can supply significant energy when the battery voltage is lower than the required voltage for system power ICs. By combining built-in power transistors, synchronous rectification, and low supply current, this IC provides a compact solution for systems using advanced Lilon battery chemistries.

The FAN48623 is a boost regulator designed to provide a minimum output voltage from a single-cell Li-lon battery, even when the battery voltage is below system minimum. The output voltage regulation is guaranteed up to a maximum load current of 2500 mA. The regulator transitions smoothly between Bypass and normal Boost Mode. The device can be forced into Bypass Mode to reduce quiescent current.

The FAN48623 is available in a 16-bump, 0.4 mm pitch, Wafer-Level Chip-Scale Package (WLCSP).

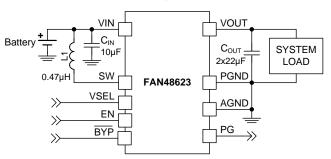


Figure 1. Typical Application

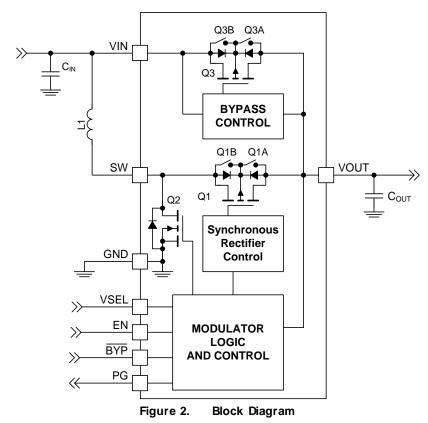
# **Ordering Information**

Part Number	Output Voltage <sup>(1)</sup> V <sub>SEL0</sub> / V <sub>SEL1</sub>	Operating Temperature	Package	Packing	Device Marking
FAN48623UC315X	3.150 / 3.330				JK
FAN48623UC32JX	3.20 / 3.413	1			JD
FAN48623UC33X	3.300 / 3.489	1			JE
FAN48623UC35X	3.5 / 3.7	-40°C to 85°C	16-Ball, 4x4 Array, 0.4 mm Pitch, 250 µm Ball, Wafer-Level Chip-Scale Package (WLCSP)	Tape & Reel	JF
FAN48623UC36FX	3.64/ 3.709	]	······································		JG
FAN48623UC50X	5.000 / 5.286	1			JL
FAN48623UC50GX	5.000 / 5.190				JM

#### Note:

1. Other output voltages are available on request. Please contact a ON Semiconductor Semiconductor representative.

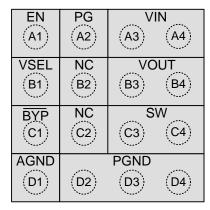
# **Typical Application**



**Table 1. Recommended Components** 

	<u> </u>				
Component	Description	Vendor	Parameter	Тур.	Unit
L1	0.47 μH, 20%, 5.3 A, 2520	Toko: DFE252010P-R47M	L	0.47	μH
LI	0.47 μπ, 20%, 3.3 Α, 2320	10KO. DI 12320101-1147 W	DCR (Series R)	27	mΩ
CIN	10 μF, 20%, 10 V, X5R, 0603	TDK: C1608X5R1A106M	С	10	μF
COUT	2 x 22 μF, 20%, 10 V, X5R, 0603	TDK: C1608X5R1A226M080AC	С	44	μF

# **Pin Configuration**





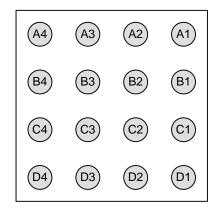


Figure 4. Bottom View (Bumps Up)

## **Pin Definitions**

Pin #	Name	Description
A1	EN	Enable. When this pin is HIGH, the circuit is enabled.
A2	PG	<b>Power Good</b> . This is an open-drain output. PG is actively pulled LOW if output falls out of regulation due to overload or if thermal protection threshold is exceeded.
A3, A4	VIN	Input Voltage. Connect to Li-lon battery input power source.
B1	VSEL	Output Voltage Select. When boost is running, this pin can be used to select the output voltage.
B3, B4	VOUT	Output Voltage. Place Cout as close as possible to the device.
C1	BYP	<b>Bypass</b> . This pin can be used to activate Forced Bypass Mode. When this pin is LOW, the bypass switches (Q3 and Q1) are turned on and the IC is otherwise inactive.
C3, C4	SW	Switching Node. Connect to inductor.
D1	AGND	Analog Ground. This is the signal ground reference for the IC. All voltage levels are measured with respect to this pin. AGND should be connected to PGND at a single point.
D2 — D4	PGND	<b>Power Ground</b> . This is the power return for the IC. The C <sub>OUT</sub> bypass capacitor should be returned with the shortest path possible to these pins.
B2, C2	NC	No Internal Connection. Note: Bumps are present and should be tied to PGND.

## **Absolute Maximum Ratings**

Stresses exceeding the absolute maximum ratings may damage the device. The device may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only.

Symbol	Parameter			Max.	Unit
V <sub>IN</sub>	V <sub>IN</sub> Input Voltage		-0.3	6.5	V
Vout	V <sub>OUT</sub> Output Voltage			6.0	V
Vsw	SW Node Voltage	DC	-0.3	6.0	V
V 500	SW Node Vollage	Transient: 10 ns, 3 MHz	-1.0	8.0	V
	Other Pins		-0.3	6.5 <sup>(2)</sup>	V
ESD	Electrostatic Discharge	Human Body Model, ANSI/ESDA/JEDEC JS-001-2012	2.0		kV
	Protection Level	Charged Device Model per JESD22-C101	1.5		ΚV
TJ	Junction Temperature		-40	+150	°C
T <sub>STG</sub>	Storage Temperature		-65	+150	°C
TL	Lead Soldering Tempera	ture, 10 Seconds		+260	°C

#### Note:

## **Recommended Operating Conditions**

The Recommended Operating Conditions table defines the conditions for actual device operation. Recommended operating conditions are specified to ensure optimal performance to the datasheet specifications. ON Semiconductor does not recommend exceeding them or designing to absolute maximum ratings.

Symbol	Parameter	Min.	Max.	Unit
V <sub>IN</sub>	Supply Voltage	2.5	4.5	V
Юит	Output Current	0	2500	mA
T <sub>A</sub>	Ambient Temperature	-40	+85	°C
TJ	Junction Temperature	-40	+125	°C

## **Thermal Properties**

Junction-to-ambient thermal resistance is a function of application and board layout. This data is measured with four-layer ON Semiconductor evaluation boards (1 oz copper on all layers). Special attention must be paid not to exceed junction temperature  $T_{J(max)}$  at a given ambient temperate  $T_A$ .

Symbol	Parameter	Typical	Unit
θЈА	Junction-to-Ambient Thermal Resistance	60	°C/W

Lesser of 6.5 V or V<sub>IN</sub> + 0.3 V.

# **Electrical Specifications**

Unless otherwise noted and per Figure 1 minimum and maximum values are from  $V_{IN}$ =2.5 V to 4.5 V and  $T_A$ =-40°C to +85°C. Typical values are at  $V_{IN} = 3.0 \text{ V}$  and  $T_A = 25^{\circ}\text{C}$  for all output voltage options.

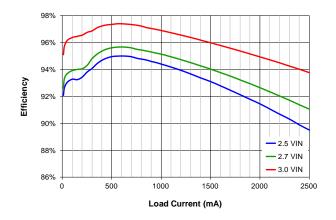
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
		Automatic Bypass Mode, $V_{OUT\_TARGET}$ =3.3 V, $V_{IN}$ =3.6 V		140	190	μА
lQ	V <sub>IN</sub> Quiescent Current	Boost Mode, V <sub>OUT</sub> =3.3 V, V <sub>IN</sub> =3.0 V		135	180	μΑ
		Shutdow n, EN=0 V, V <sub>IN</sub> =3.0 V		4.0	12.0	μΑ
		Forced Bypass Mode, V <sub>IN</sub> =3.6 V		6.0	12.0	μΑ
ILK	V <sub>OUT</sub> to V <sub>IN</sub> Reverse Leakage	V <sub>OUT</sub> =5.0 V, EN=0 V, V <sub>IN</sub> =0 V		0.5	1.0	μΑ
ILK_OUT	V <sub>IN</sub> to V <sub>OUT</sub> Leakage Current	V <sub>OUT</sub> =0 V, EN=0 V, V <sub>IN</sub> =4.2 V		0.1	1.5	μΑ
$V_{UVLO}$	Under-Voltage Lockout	V <sub>IN</sub> Rising		2.20	2.35	V
V <sub>UVLO_HYS</sub>	Under-Voltage Lockout Hysteresis			200		mV
V <sub>IH</sub>	Logic Level High EN, VSEL, BYP		1.05			V
V <sub>IL</sub>	Logic Level Low EN, VSEL, BYP				0.4	V
R <sub>LOW</sub>	Logic Control Pin Pull Downs (LOW Active)	BYP, VSEL, EN		300		kΩ
l <sub>PD</sub>	Weak Current Source Pull-Down	BYP, VSEL, EN		100		nA
$V_{REG}$	Output Voltage Accuracy	$2.5 \text{ V} \le \text{V}_{\text{IN}} \le \text{V}_{\text{OUT\_TARGET}} - 100 \text{ mV}, DC, 0 \text{ to}$ 2500 mA	-1.0		4.0	%
V REG	Output Vollage Accuracy	2.5 V $\leq$ V <sub>IN</sub> $\leq$ V <sub>OUT_TARGET</sub> -100 mV, DC, PWM (CCM) Operation	-1.0		2.5	%
l√_LIM	Boost Valley Current Limit	V <sub>IN</sub> =2.5 V, V <sub>OUT</sub> =3.3 V	4.7	5.3		Α
lv_LIM_SS	Boost Valley Current Limit During Soft Start	V <sub>IN</sub> =2.5 V, V <sub>OUT</sub> =3.3 V		2.6		Α
t <sub>SS</sub>	Soft-Start EN HIGH to Regulation	50 $\Omega$ Load, V <sub>OUT_TARGET</sub> = 3.3 V (Time from EN Rising Edge to 90% of V <sub>OUT_TARGET</sub> )		300		μs
t <sub>RST</sub>	FAULT Restart Timer			20		ms

#### Note:

Minimum and Maximum limits are verified by design, test, or statistical analysis. Typical (Typ.) numbers are not verified, but represent typical results.

## Typical Characteristics

Unless otherwise specified, TA = 25°C; circuit and components according to Figure 1.



98% 94% 92% 90% 40C 88% +25C +85C 86% 500 1000 1500 2000 2500 Load Current (mA)

Efficiency vs. Load Current and Input Figure 5. Voltage, Vout=3.15 V

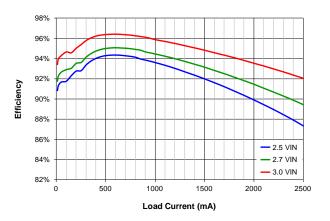
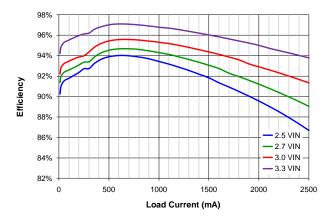


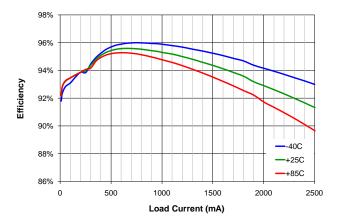
Figure 6. Efficiency vs. Load Current and Temperature, V<sub>IN</sub>=3.0 V, V<sub>OUT</sub>=3.15 V



Figure 7. Efficiency vs. Load Current and Input Voltage, Vout=3.3 V



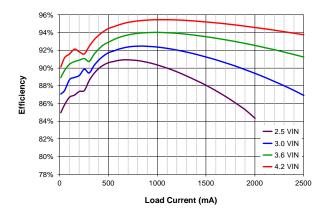
Efficiency vs. Load Current and Temperature, ViN=3.0 V, Vout=3.3 V



Efficiency vs. Load Current and Input Figure 9. Voltage, Vout=3.5 V

Efficiency vs. Load Current and Figure 10. Temperature, V<sub>IN</sub>=3.0 V, V<sub>OUT</sub>=3.5 V

Unless otherwise specified, TA = 25°C; circuit and components according to Figure 1.



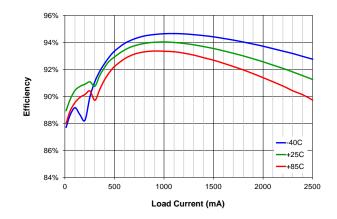


Figure 11. Efficiency vs. Load Current and Input Voltage, Vout=5.0 V

Figure 12. Efficiency vs. Load Current and Temperature,  $V_{IN}$ =3.6 V,  $V_{OUT}$ =5.0 V



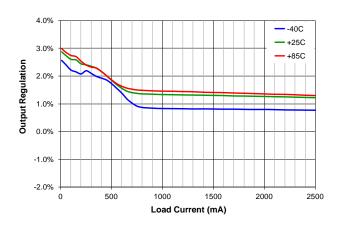
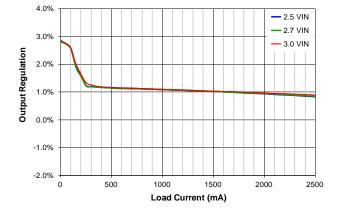


Figure 13. Output Regulation vs. Load Current and Input Voltage, V<sub>OUT</sub>=3.15 V

Figure 14. Output Regulation vs. Load Current and Temperature,  $V_{IN}$ =3.0 V,  $V_{OUT}$ =3.15 V



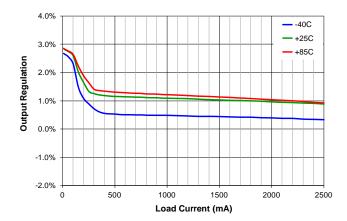
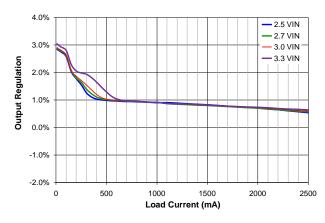


Figure 15. Output Regulation vs. Load Current and Input Voltage, V<sub>OUT</sub>=3.3 V

Figure 16. Output Regulation vs. Load Current and Temperature, V<sub>IN</sub>=3.0 V, V<sub>OUT</sub>=3.3 V

Unless otherwise specified, T<sub>A</sub> = 25°C; circuit and components according to Figure 1.



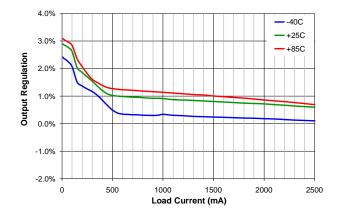
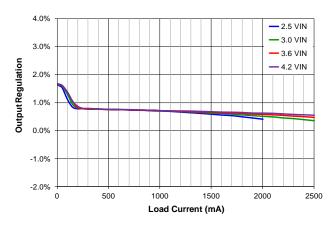


Figure 17. Output Regulation vs. Load Current and Input Voltage, VouT=3.5 V

Figure 18. Output Regulation vs. Load Current and Temperature,  $V_{\text{IN}}$ =3.0 V,  $V_{\text{OUT}}$ =3.5 V



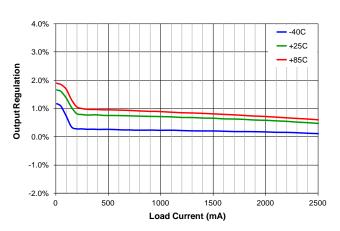
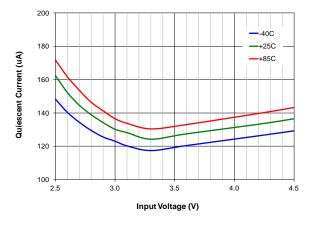


Figure 19. Output Regulation vs. Load Current and Input Voltage,  $V_{OUT}$ =5.0 V

Figure 20. Output Regulation vs. Load Current and Temperature,  $V_{\text{IN}}$ =3.6 V,  $V_{\text{OUT}}$ =5.0 V



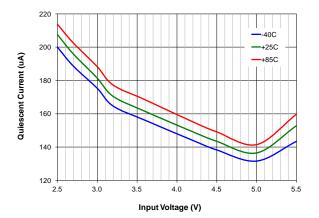
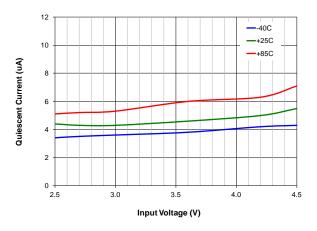


Figure 21. Quiescent Current vs. Input Voltage and Temperature, V<sub>OUT</sub>=3.15 V, Auto Bypass

Figure 22. Quiescent Current vs. Input Voltage and Temperature, V<sub>OUT</sub>=5.0 V, Auto Bypass

Unless otherwise specified, T<sub>A</sub> = 25°C; circuit and components according to Figure 1.



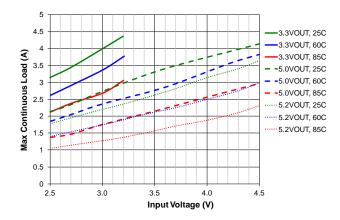


Figure 23. Quiescent Current vs. Input Voltage and Temperature, Vout=3.3 V, Forced Bypass

Figure 24. Typical Maximum Continuous Load vs. Input Voltage, Temperature and Output Voltage



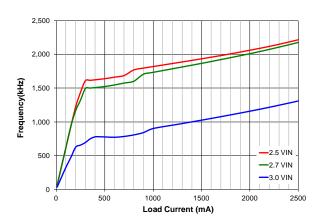
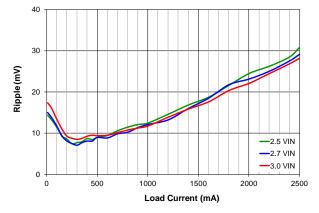


Figure 25. Output Ripple vs. Load Current and Input Voltage, Vout=3.15 V

Figure 26. Frequency vs. Load Current and Input Voltage, V<sub>OUT</sub>=3.15 V



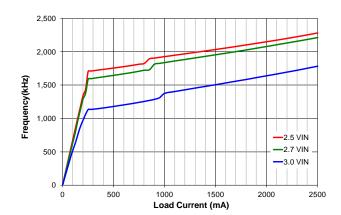
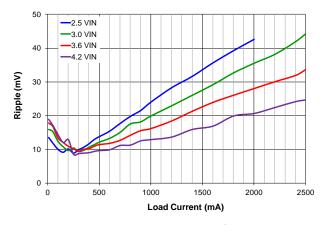


Figure 27. Output Ripple vs. Load Current and Input Voltage, Vout=3.3 V

Figure 28. Frequency vs. Load Current and Input Voltage,  $V_{\text{OUT}}$ =3.3 V

Unless otherwise specified,  $T_A = 25$ °C; circuit and components according to Figure 1.



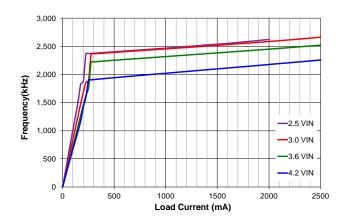
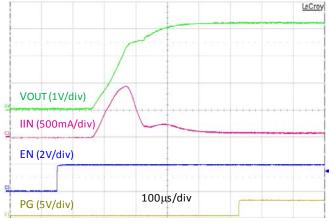


Figure 29. Output Ripple vs. Load Current and Input Voltage, Vout=5.0 V

Figure 30. Frequency vs. Load Current and Input Voltage,  $V_{\text{OUT}}$ =5.0 V



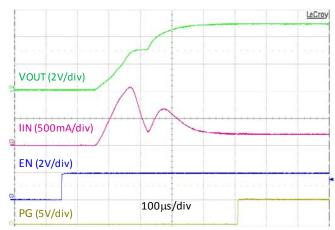


Figure 31. Startup, 50  $\Omega$  Load,  $V_{IN}$ =2.5 V,  $V_{OUT}$ =3.15 V

Figure 32. Startup, 50  $\Omega$  Load,  $V_{IN}$ =3.0 V,  $V_{OUT}$ =5.0 V

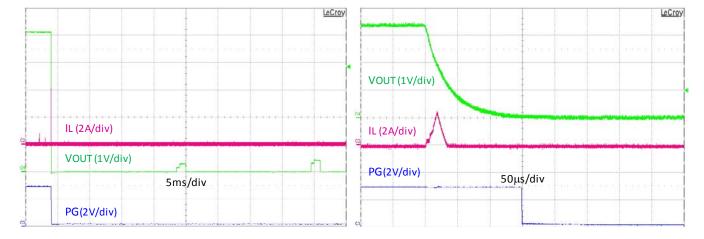
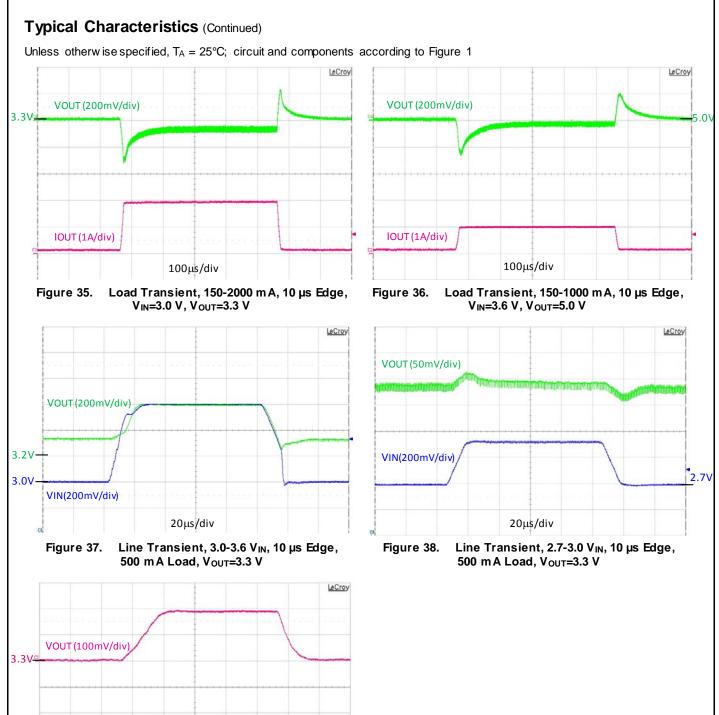


Figure 33. Overload Protection, V<sub>IN</sub>=3.0 V, V<sub>OUT</sub>=5.0 V

Figure 34. Output Fault, V<sub>IN</sub>=3.0 V, V<sub>OUT</sub>=3.3 V



20μs/div Figure 39.  $V_{SEL}$  Step,  $V_{IN}=3$  V,  $V_{OUT}=3.3$  V, 500 m A Load

VSEL (2V/div)

## **Circuit Description**

FAN48623 is a synchronous boost regulator, typically operating at 2.5 MHz in Continuous Conduction Mode (CCM), which occurs at moderate to heavy load current and low  $V_{\rm IN}$  voltages. At light load, the regulator operates at Discontinuous Conduction Mode (DCM) to maintain high efficiency.

FAN48623 uses a current-mode modulator to achieve excellent transient response and smooth transitions between CCM and DCM operation.

The regulator includes a Bypass Mode that automatically activates when  $V_{\text{IN}}$  is above the boost regulator's set point.

Table 2. Operating States

Mode	Description	Invoked When
LIN	Linear Startup	V <sub>IN</sub> > V <sub>OUT</sub>
SS	Soft-Start Mode	V <sub>IN</sub> <v<sub>OUT &lt; V<sub>OUT_TARGET</sub></v<sub>
BST	Boost Operating Mode	Vout = Vout_target
BPS	Bypass Mode	V <sub>IN</sub> > V <sub>OUT_TARGET</sub>

#### Startup and Shutdown (EN Pin)

If EN is LOW, all bias circuits are off and the regulator is in Shutdown Mode. During shutdown, current flow is prevented from VIN to VOUT, as well as reverse flow from VOUT to VIN. During startup, keep DC current draw below 500 mA until the device successfully executes startup. It is recommended not to connect EN directly to VIN but use a GPIO voltage of 1.8 V to set the logic for the EN pin. The following table describes the startup sequence.

Table 3. Boost Startup Sequence

Start Mode	Entry	Exit	End Mode	Timeout (µs)
LIN1	VIN > VUVLO,	$V_{OUT} > V_{IN}$ -300 mV	SS	
LINI	EN=1	TIMEOUT	LIN2	512
		$V_{OUT} > V_{IN}$ -300 mV	SS	
LIN2	LIN1 Exit	TIMEOUT	FAUL T	1024
SS	LIN1 or LIN2 Exit	Vout=Vout_target	BST	

#### Linear Startup (LIN)

When EN is HIGH and  $V_{IN} > V_{UVLO}$ , the regulator attempts to bring  $V_{OUT}$  within 300 mV of  $V_{IN}$  using the internal fixed current source from  $V_{IN}$  (Q3). The current is limited to the LIN1 (~1 A) set point.

If  $V_{OUT}$  reaches  $V_{\text{IN}}\text{-}300\,\text{mV}$  during LIN1 Mode, SS Mode is initiated. Otherwise, LIN1 times out after 512  $\mu s$  and LIN2 Mode is entered.

In LIN2 Mode, the current source is incremented to approximately 2 A. If  $V_{OUT}$  fails to reach  $V_{IN}$ -300 mV after 1024  $\mu s$ , a fault state is declared.

#### Soft-Start Mode (SS)

Upon successful completion of the LIN Mode (V<sub>OUT</sub>≥V<sub>IN</sub>-300 mV), SS Mode begins and the regulator starts switching

with boost valley current limited to 50% of nominal level at Boost Mode.

During SS Mode,  $V_{OUT}$  is ramped up by stepping the internal reference. If  $V_{OUT}$  fails to reach the voltage required during the SS ramp sequence within 64  $\mu$ s, a fault state is declared.

#### **Boost Mode (BST)**

This is a normal operating state of the regulator.

#### Bypass Mode (BPS)

If  $V_{IN}$  is above  $V_{OUT\_TARGET}$  when the SS Mode successfully completes, the device transitions directly to BPS Mode.

Table 4. EN and BYP Logic Table

EN	BYP	Mode	V <sub>out</sub>
0	0	Shutdow n	0
	1	Shutdow n	0
	0	Forced Bypass	V <sub>IN</sub>
1	1	Auto Bypass	VOUT_TARGET OF VIN (if VIN > VOUT_TARGET)

#### **FAULT State**

The regulator enters the FAULT state under any of the following conditions:

- V<sub>OUT</sub> fails to achieve the voltage required to advance from LIN state to SS state.
- V<sub>OUT</sub> fails to achieve the voltage required to advance from SS state to BST state.
- Boost valley current limit triggers for 2 ms during the BST state.
- V<sub>IN</sub> to V<sub>OUT</sub> voltage drop exceeds 160 mV during BPS state.
- V<sub>IN</sub> < V<sub>UVLO</sub>

If a fault is triggered, the regulator stops switching and presents a high-impedance path between VIN and VOUT. After waiting 20 ms, an automatic restart is attempted.

#### **Power Good**

Power good is defined as a 0-FAULT, 1-POWER GOOD, open-drain output. The Power Good pin (PG) signals when the regulator has successfully completed soft-start with no faults occurring. Power Good also functions as a warning flag for high die temperature.

- PG is released HIGH when the soft-start sequence is successfully completed.
- Any FAULT state causes PG to be de-asserted.
- PG is not asserted during Forced Bypass exit to Boost Mode until the soft-start sequence is successfully completed.

#### **Over-Temperature**

When the die temperature exceeds 125°C, PG de-asserts and the output remains regulated. PG is re-asserted when the device cools by approximately 20°C.

The regulator shuts down if the die temperature exceeds 150°C. Restart occurs when the IC has cooled by approximately 20°C.

#### **Automatic Bypass**

In normal operation, the device automatically transitions from Boost Mode to Bypass Mode if  $V_{\text{IN}}$  goes above  $V_{\text{OUT\_TARGET}}$ . In Bypass Mode, the device fully enhances both Q1 and Q3 to provide a very low impedance path from VIN to VOUT. Entry into the Bypass Mode is triggered when  $V_{\text{IN}} > V_{\text{OUT\_TARGET}}$  and no switching has occurred during the past 10  $\mu s$ . To soften the entry into Bypass Mode, Q3 is driven as a linear current source for the first 5  $\mu s$ . Bypass Mode exit is triggered when  $V_{\text{OUT}}$  reaches  $V_{\text{OUT\_TARGET}}$ . During Automatic Bypass Mode, the device is short-circuit protected by voltage comparator tracking the voltage drop from  $V_{\text{IN}}$  to  $V_{\text{OUT}}$ ; if the drop exceeds 160 mV, a fault state is declared.

With sufficient load to enforce CCM operation, the Bypass Mode to Boost Mode transition occurs at the target  $V_{OUT}$ . The Bypass Mode exit threshold has a 50 mV hysteresis imposed at  $V_{OUT}$  to prevent cycling between modes. The corresponding input voltage at the transition point is:

$$V_{IN} \le V_{OUT} + I_{LOAD} \bullet (DCR_L + R_{DS(ON)P}) || R_{DS(ON)BYP} - 50mV$$
 (1)

The Bypass Mode entry threshold has a 30 mV hysteresis imposed at  $V_{OUT}$  to prevent cycling between modes. The transition from Boost Mode to Bypass Mode occurs at the target  $V_{OUT}$ +30 mV. The corresponding input voltage is:

$$V_{IN} \ge V_{OUT} + I_{LOAD} \bullet (DCR_L + R_{DS(ON)P}) + 30mV$$
 (2)

## **Forced Bypass**

Forced Bypass Mode is activated by pulling  $\overline{\text{BYP}}$  pin LOW. Forced Bypass Mode initiates with a current limit on Q3 and then proceeds to the Bypass Mode with both Q1 and Q3 fully enhanced. To prevent reverse current to the battery, the device waits until output discharges below  $V_{\text{IN}}$  before entering Forced Bypass Mode.

After the transition is complete, most of the internal circuitry is disabled to minimize quiescent current. OCP, UVLO and OTP are inactive in Forced Bypass Mode.

By pulling  $\overline{BYP}$  pin HIGH, the part transitions from Forced Bypass Mode to Boost Mode. During the transition, Q1 is off and Q3 is driven as a linear current source for the first 5  $\mu$ s before entering Boost Mode.

## **Application Information**

# Output Capacitance (Cout)

#### **Stability**

The effective capacitance ( $C_{\text{EFF}}^{(4)}$ ) of small, high-value, ceramic capacitors decrease as bias voltage increases, as illustrated in Figure 40.

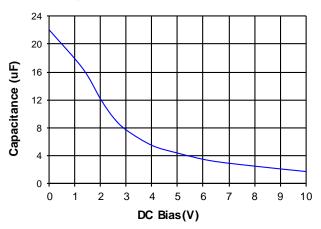


Figure 40. C<sub>EFF</sub> for 22 μF, 0603, X5R, 10 V-Rated Capacitor (TDK C1608X5R1A226M080AC)

Stable operation is guaranteed with the minimum value of  $C_{\mathsf{EFF}}$  ( $C_{\mathsf{EFF}(\mathsf{MIN})}$ ), as outlined in Table 5.

Table 5. Minimum  $C_{EFF}$  Required for Stability

Operating	C (E)	
V <sub>OUT</sub> (V) I <sub>LOAD</sub> (mA)		C <sub>EFF(MIN)</sub> (μF)
3.15	0 to 2500	9
5.0	0 to 2500	6

#### Note:

4. C<sub>EFF</sub> varies with manufacturer, material, and case size.

#### Inductor Selection

Recommended nominal inductance value is 0.47  $\mu H$ .

The FAN48623 employs valley-current limiting. Peak inductor current can reach 6.5 A for a short duration during overload conditions. Saturation effects cause the inductor current ripple to become higher under high loading as only the valley of the inductor current ripple is controlled.

#### **Startup Inrush Current Limit**

Input current limiting is in effect during soft-start, which limits the current available to charge  $C_{\text{OUT}}$  and any additional capacitance on the  $V_{\text{OUT}}$  line. If the output fails to achieve regulation within the set limit, a FAULT occurs, causing the circuit to shut down then restart after 20 ms. If the total combined output capacitance is very high, the circuit may not start on the first attempt, but eventually achieves regulation if no load is present. If a high-current load and high capacitance are both present during soft-start, the circuit may fail to achieve regulation and continually attempts soft-start, only to have the output capacitance discharged by the load when in a FAULT state.

### **Output Voltage Ripple**

Output voltage ripple is inversely proportional to  $C_{\text{OUT}}$ . During  $t_{\text{ON}}$ , when the boost switch is on, all load current is supplied by  $C_{\text{OUT}}$ . Output ripple is calculated as:

$$V_{RIPPLE(P-P)} = t_{ON} \bullet \frac{I_{LOAD}}{C_{OUT}}$$
(3)

and

$$t_{ON} = t_{SW} \bullet D = t_{SW} \bullet \left(1 - \frac{V_{IN}}{V_{OUT}}\right)$$
(4)

therefore:

$$V_{RIPPLE(P-P)} = t_{SW} \bullet \left(1 - \frac{V_{IN}}{V_{OUT}}\right) \bullet \frac{I_{LOAD}}{C_{OUT}}$$
(5)

and

$$t_{SW} = \frac{1}{f_{CW}} \tag{6}$$

As can be seen from Equation (5), the maximum  $V_{RIPPLE}$  occurs when  $V_{IN}$  is at minimum and  $I_{LOAD}$  is at maximum.

## **Voltage at VOUT**

For applications where a foreign voltage source could be applied at VOUT, care should be taken to ensure  $V_{\text{OUT}}$  never exceeds the Absolute Maximum Rating.

## **Layout Recommendations**

The layout recommendations below highlight various layers using different colors.

To minimize spikes at  $V_{\text{OUT}}$ ,  $C_{\text{OUT}}$  must be placed as close as possible to PGND and VOUT, as shown in Figure 41.

For thermal reasons, it is suggested to maximize the pour area for all planes other than SW. Especially the ground pour should be set to fill all available PCB surface area and tied to internal layers with a cluster of thermal vias.

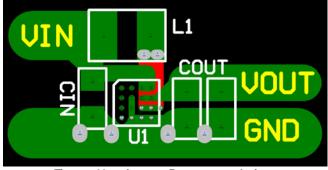


Figure 41. Layout Recommendation

Refer to the section below for detailed layout recommendations for each layer.

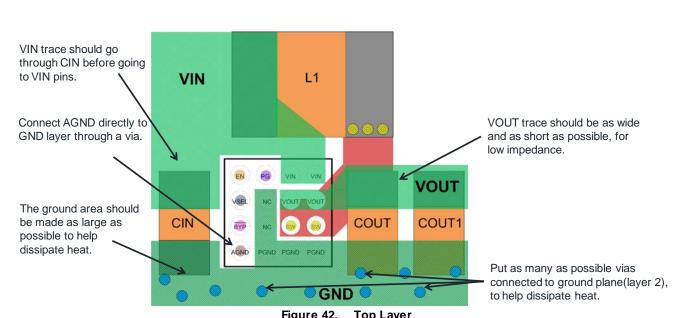
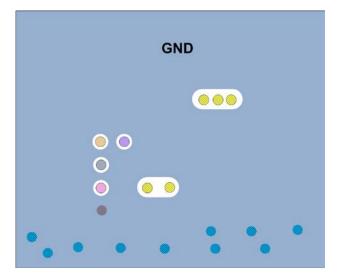
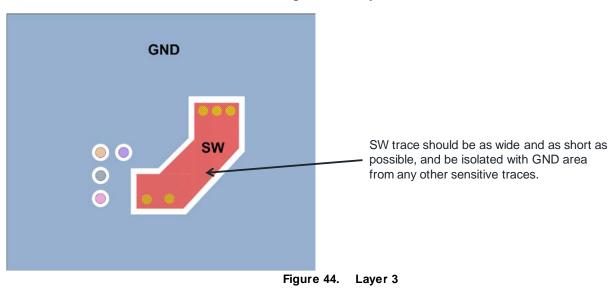


Figure 42. Top Layer



- Layer 2 should be a solid ground layer, to shield VOUT from capacitive coupling of the fast edges of SW node.
- Logic signals can be routed on this layer.

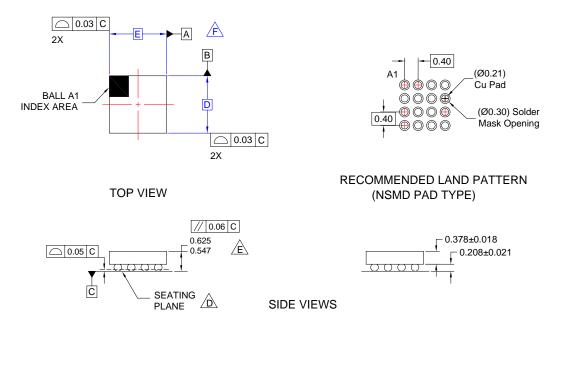
Figure 43. Layer 2

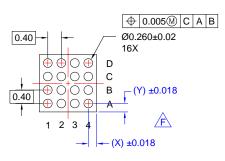


# **Product-Specific Dimensions**

Product	D	E	Х	Y
FAN48623UC315X	1.810 ±0.030	1.810 ±0.030	0.305	0.305
FAN48623UC32JX	1.810 ±0.030	1.810 ±0.030	0.305	0.305
FAN48623UC33X	1.810 ±0.030	1.810 ±0.030	0.305	0.305
FAN48623UC35X	1.810 ±0.030	1.810 ±0.030	0.305	0.305
FAN48623UC36FX	1.810 ±0.030	1.810 ±0.030	0.305	0.305
FAN48623UC50X	1.810 ±0.030	1.810 ±0.030	0.305	0.305
FAN48623UC50GX	1.810 ±0.030	1.810 ±0.030	0.305	0.305

## **Physical Dimensions**





**BOTTOM VIEW** 

#### **NOTES**

- A. NO JEDEC REGISTRATION APPLIES.
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCE PER ASME Y14.5M, 1994.
- $^\prime$ D $^\prime$ DATUM C IS DEFINED BY THE SPHERICAL CROWNS OF THE BALLS.
- E. PACKAGE NOMINAL HEIGHT IS
- 586 ± 39 MICRONS (547-625 MICRONS). F.\FOR DIMENSIONS D,E,X, AND Y SEE PRODUCT DATASHEET.
- G. DRAWING FILNAME: MKT-UC016AF rev1

16-Ball, 4x4 Array, 0.4 mm Pitch, 250 µm Ball, Wafer-Level Chip-Scale Package (WLCSP)

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